Acta Cryst. (1995). A51, 589

Bloch-wave degeneracies and nonsystematic critical voltage: a method for structure-factor determination. Erratum. By H. Matsuhata and J. Gjønnes, Department of Physics, University of Oslo, PO Box 1048 Blindern, 0316 Oslo, Norway

(Received 5 January 1995; accepted 20 February 1995)

Abstract

Corrections are given for the paper by Matsuhata & Gjønnes [Acta Cryst. (1994), A50, 107-115].

Page 108, left column, line 22, change $m/m_o = \gamma$ to $m/m_o = \beta$. Page 108, equation (1), change

$$(2ks_3 + 2k\gamma + U_{13}^2/2k\gamma)$$

to

$$(2ks_3 - 2k\gamma + U_{13}^2/2k\gamma).$$

Page 108, right column, line 13, change

$$[(1/\gamma) + (U_{23}/U_{21}U_{13})]$$

to

$$[(1/\gamma) + (U_{32}/U_{21}U_{13})].$$

Page 109, left column, lines 30 and 31, change $U_{13}=U_{14}=U_{23}=U_{24}=f$ to $U_{13}=U_{14}=U_{23}=U_{24}=U_{f}$. Page 109, right column, line 3, change

$$2k_4s_4 = (h^2 - g^2)/4 + h\varepsilon$$

to

$$2k_4s_4 = (h^2 - g^2)/4 + g\delta + h\varepsilon.$$

Page 109, right column, line 4, change

$$2ks_2 = g\varepsilon$$

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to

$$ks_2 = h\varepsilon$$
.

Page 109, equations (4), change second equation to

$$[(h^2 - g^2)/4] - g\delta + h\varepsilon + (U_f^2/\gamma) - \gamma$$
$$= U_f^2[(1/\gamma) + (U_g/U_f^2)].$$

Page 109, equation (5), change to

$$h\varepsilon = \pm \left(\left\{ -\left[\left(h^2 - g^2 \right) / 4 \right] + \left(-2U_f^2 + U_g^2 + U_g U_h \right) / U_g \right\}$$
$$\times \left\{ -\left[\left(h^2 - g^2 \right) / 4 \right] + U_g - U_h \right\} \right)^{1/2}.$$

Page 111, left column, line 6, change $\gamma = U_{34}$ to $\gamma = -U_{34}$. Page 112, left column, change

$$[U_{220} + U_{400}/U_{200}]$$

to

$$[(U_{220} + U_{400})/U_{200}].$$

Page 114, right column, last line of equation, change

$$\left[\left(2ks-U_4-U_1\right)^2/4\right]$$

to

$$[(2ks-U_4+U_1)^2/4].$$

All relevant information is given in the Abstract.

Acta Cryst. (1995). A51, 589

A study of the structure factors in rutile-type SnO₂ by high-energy electron diffraction. Erratum. By H. Matsuhata,* J. Gjønnes and J. Taftø, Department of Physics, University of Oslo, PO Box 1048 Blindern, 0316 Oslo, Norway

(Received 5 January 1995; accepted 20 February 1995)

Abstract

Corrections are given for the paper by Matsuhata, Gjønnes & Taftø [Acta Cryst. (1994), A50, 115-123].

Page 118, left column, line 17, change $U_{200} > U_{011} > U_{020}$ to $U_{002} > U_{011} > U_{020}$.

Page 118, right column, line 21, change O^{2+} to O^{2-} .

Page 120, right column, line 33, change -0.8 (0) to -0.8 (10).

Page 121, equation (4) should read:

$$E_c = (m_o c^2 / e) \{ U_{002} (g_{002}^2 - g_{020}^2) \times \left[4 (2U_{011}^2 - U_{002}^2 - U_{020} U_{002}) \right]^{-1} - 1 \}.$$
 (4)

Page 121, left column, line 25, change

$$F_{002} = 2f_{\rm Sn} - 4.000f_{\rm O}$$

to

$$F_{002} = 2f_{\rm Sn} + 4.000f_{\rm O}$$
.

All relevant information is given in the Abstract.

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